## **Power MOSFET**

## 30 V, 27 A, Single N–Channel, $\mu$ 8FL

### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- DC–DC Converters
- Power Load Switch
- Notebook Battery Management

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	7.7	А
Current $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 85°C		5.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	PD	1.63	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	12.2	А
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		$T_A = 85^{\circ}C$		9.1	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	4.1	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	5.0	А
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C		3.8	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.69	W
Continuous Drain		$T_{C} = 25^{\circ}C$	I <sub>D</sub>	27	А
Current $R_{\theta JC}$ (Note 1)		$T_{C} = 85^{\circ}C$		20	
Power Dissipation $R_{\theta JC}$ (Note 1)		$T_{C} = 25^{\circ}C$	P <sub>D</sub>	20.2	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	81	А
Operating Junction and S	Operating Junction and Storage Temperature			–55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	17	А
Drain to Source dV/dt			dV/dt	6.0	V/ns
$ \begin{array}{l} \mbox{Single Pulse Drain-to-Source Avalanche Energy} \\ (T_J = 25^\circ C, V_{DD} = 50 \ V, V_{GS} = 10 \ V, \\ I_L = 16 \ A_{pk}, \ L = 0.1 \ mH, \ R_G = 25 \ \Omega) \ (Note 3) \end{array} $			E <sub>AS</sub>	13	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum rating. Parts are 100% tested at  $T_J = 25^{\circ}C$ ,

 $V_{GS} = 10 \text{ V}, \text{ I}_{L} = 11 \text{ Apk}, \text{ E}_{AS} = 6 \text{ mJ}.$ 

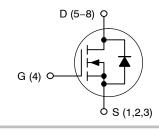


### **ON Semiconductor®**

### http://onsemi.com

V <sub>(BR)DSS</sub>	V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> MAX	
30 V	17 mΩ @ 10 V	27 A
30 V	26.5 mΩ @ 4.5 V	21 A







WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTTFS4C25NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4C25NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter		Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	6.2	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	76.7	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	210	-0/00
Junction-to-Ambient – (t $\leq$ 10 s) (Note 4)	$R_{\thetaJA}$	30.8	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	V <sub>GS</sub> = 0 V, I <sub>D(ava</sub> T <sub>case</sub> = 25°C, t <sub>trans</sub>	$V_{GS}$ = 0 V, $I_{D(aval)}$ = 4.4 A, T <sub>case</sub> = 25°C, t <sub>transient</sub> = 100 ns				V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				15.3		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		$V_{DS} = 24 V$	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.3		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 10 A			13	17	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 9 A		21	26.5	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			23		S
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°C			1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				500		Τ
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH	z, V <sub>DS</sub> = 15 V		295		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				85		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15	5 V, f = 1 MHz		0.170		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.1		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 20 A			0.9		
Gate-to-Source Charge	Q <sub>GS</sub>				1.7		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				2.7		
Gate Plateau Voltage	V <sub>GP</sub>				3.3		V
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V; $I_{D}$ = 20 A			10.3		nC
SWITCHING CHARACTERISTICS (Note 7)							

#### Turn-On Delay Time t<sub>d(ON)</sub> 8.0 **Rise Time** t<sub>r</sub> 32 $\begin{array}{l} \mathsf{V}_{GS} = 4.5 \; \mathsf{V}, \, \mathsf{V}_{DS} = 15 \; \mathsf{V}, \\ \mathsf{I}_{D} = 10 \; \mathsf{A}, \; \mathsf{R}_{G} = 3.0 \; \Omega \end{array}$ ns Turn-Off Delay Time 10 $t_{d(\mathsf{OFF})}$ Fall Time 3.0 t<sub>f</sub>

6. Pulse Test: pulse width  $\,\leq\,$  300  $\mu s,\,$  duty cycle  $\,\leq\,$  2%.

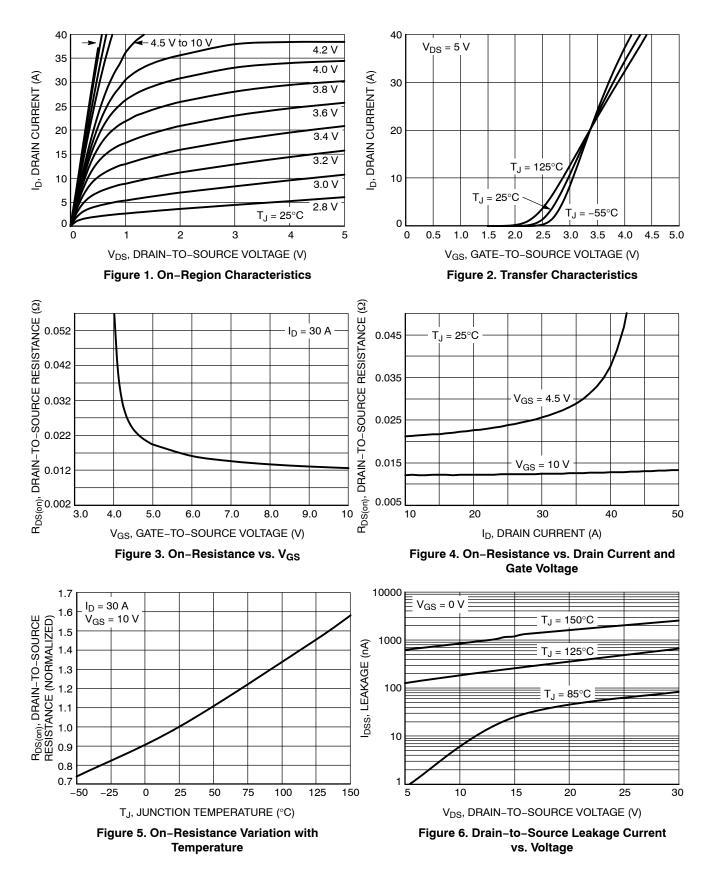
7. Switching characteristics are independent of operating junction temperatures.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

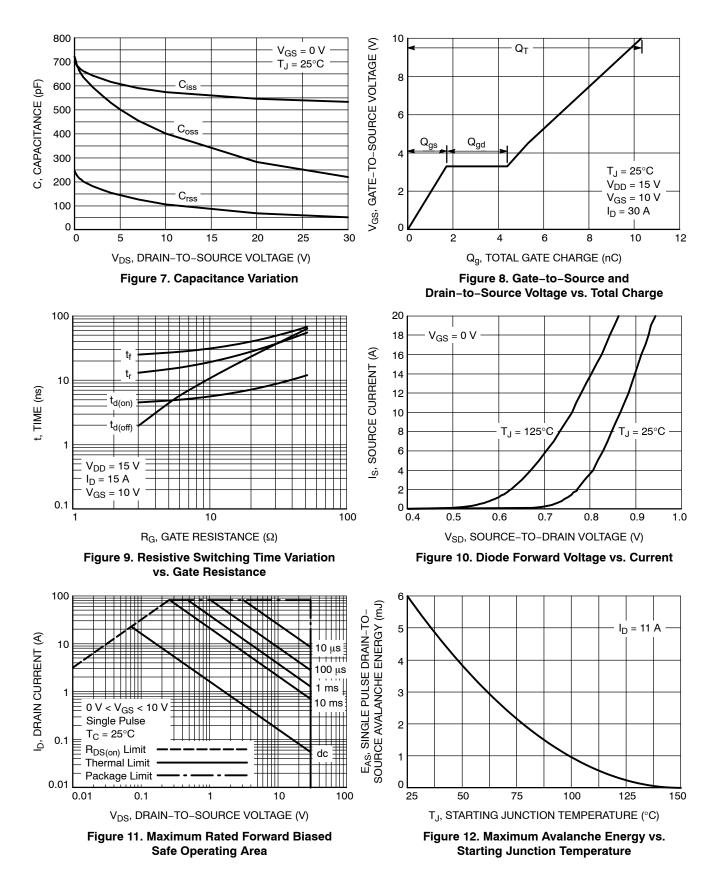
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	ote 7)			1			
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 Ω			4.0		ns
Rise Time	t <sub>r</sub>				25		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				13		
Fall Time	t <sub>f</sub>				2.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS			-			
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V, \\ I_{S} = 10 A \\ T_{J} = 25^{\circ}C \\ T_{J} = 125^{\circ}C$			0.87	1.2	.,
					0.75		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 30 A			18.2		
Charge Time	t <sub>a</sub>				9.8		ns
Discharge Time	t <sub>b</sub>				8.4		
Reverse Recovery Charge	Q <sub>RR</sub>				5.7		nC

 $\begin{array}{ll} \mbox{6. Pulse Test: pulse width } \le 300 \ \mu \mbox{s, duty cycle } \le 2\%. \\ \mbox{7. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

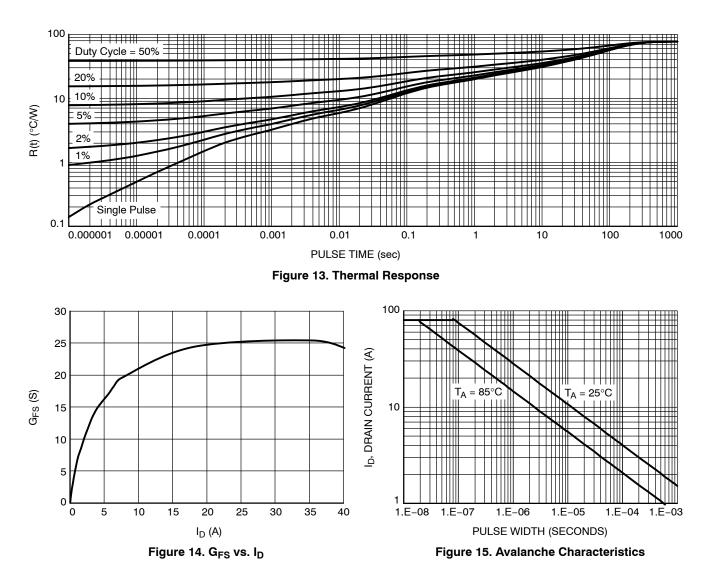
### **TYPICAL CHARACTERISTICS**



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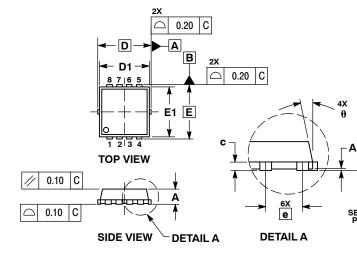


### **TYPICAL CHARACTERISTICS**



#### PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB **ISSUE D** 



8x b С A В 0.10  $\oplus$ 0.05 С e/2 4X | E2 М F3 ¥ D2 G BOTTOM VIEW

Δ1 C SEATING PLANE NOTES:

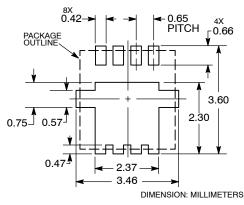
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. 2

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH

PROTRUSIONS	OR	GATE	BURRS.

	МІ	LLIMETE	RS	INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
c	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		C	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC			.130 BSC	)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC			0.026 BS0	2
G	0.30	0.41	0.51	0.012	0.016	0.020
ĸ	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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